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3-266 U.S. PRO

ISSUE CLASSIFICATION

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PATENT NUMBER

U.S. UTILITY Patent Application

E.A. O.I.P.E.

O.I.P.E.

PATENT DATE

SCANNED

639

F.A	O.I.P.E.	PATENT DATE
SCANNED	TK 3 Q.A. HT	

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701

Semiconductor test apparatus and control method therefor

TITLE

ISSUING CLASSIFICATION

Continued on Issue Slip Inside File Jacket

TERMINAL DISCLAIMER	DRAWINGS			CLAIMS ALLOWED		
	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.	
<input type="checkbox"/> The term of this patent subsequent to _____ (date) has been disclaimed.				NOTICE OF ALLOWANCE MAILED		
<input type="checkbox"/> The term of this patent shall not extend beyond the expiration date of U.S Patent. No. _____				ISSUE FEE		
<input type="checkbox"/> The terminal _____ months of this patent have been disclaimed.				ISSUE BATCH NUMBER		
	(Assistant Examiner)	(Date)	(Primary Examiner)	(Date)	(Legal Instruments Examiner)	(Date)

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